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## FDMS86520

#### October 2014

# N-Channel PowerTrench<sup>®</sup> MOSFET 60 V, 42 A, 7.4 m $\Omega$

#### **Features**

- Max  $r_{DS(on)}$  = 7.4 m $\Omega$  at  $V_{GS}$  = 10 V,  $I_D$  = 14 A
- Max  $r_{DS(on)}$  = 10.3 m $\Omega$  at  $V_{GS}$  = 8 V,  $I_D$  = 12.5 A
- Advanced Package and Silicon combination for low r<sub>DS(on)</sub> and high efficiency
- Next generation enhanced body diode technology, engineered for soft recovery
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

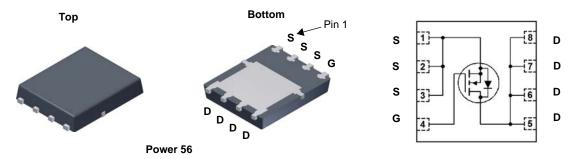


## **General Description**

This N-Channel MOSFET has been designed specifically to improve the overall efficiency and to minimize switch node ringing of DC/DC converters using either synchronous or conventional switching PWM controllers.It has been optimized for low gate charge, low  $r_{\rm DS(on)}$ , fast switching speed and body diode reverse recovery performance.

## **Applications**

- Primary DC-DC Switch
- Motor Bridge Switch
- Synchronous Rectifier



## MOSFET Maximum Ratings T<sub>A</sub> = 25 °C unless otherwise noted

Symbol	Parame	ter		Ratings	Units	
V <sub>DS</sub>	Drain to Source Voltage			60	V	
$V_{GS}$	Gate to Source Voltage			±20	V	
	Drain Current -Continuous	T <sub>C</sub> = 25 °C		42		
I <sub>D</sub>	-Continuous	T <sub>A</sub> = 25 °C	(Note 1a)	14	Α	
	-Pulsed			80		
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 3)	86	mJ	
В	Power Dissipation	T <sub>C</sub> = 25 °C		69	W	
$P_{D}$	Power Dissipation	T <sub>A</sub> = 25 °C	(Note 1a)	2.5	VV	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperat	ure Range		-55 to +150	°C	

#### **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.8	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a	50	C/VV

#### **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS86520	FDMS86520	Power 56	13 "	12 mm	3000 units

Units

## **Electrical Characteristics** $T_J = 25$ °C unless otherwise noted

Parameter

Off Characteristics								
$BV_{DSS}$	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	60			V		
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25 °C		30		mV/°C		
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 48 V, V <sub>GS</sub> = 0 V			1	μΑ		
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA		

**Test Conditions** 

Min

Тур

Max

## **On Characteristics**

Symbol

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2.5	3.6	4.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25 °C		-11		mV/°C
	Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 14 A		6.0	7.4	
r <sub>DS(on)</sub>		$V_{GS} = 8 \text{ V}, I_D = 12.5 \text{ A}$		7.3	10.3	mΩ
, ,		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 14 A, T <sub>J</sub> = 125 °C		9	11	
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 14 A		49		S

### **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V, f = 1 MHz		2140	2850	pF
C <sub>oss</sub>	Output Capacitance			624	830	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			24	40	pF
$R_g$	Gate Resistance		0.1	0.7	2.1	Ω

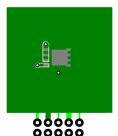
## **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time		V <sub>DD</sub> = 30 V, I <sub>D</sub> = 14 A,		17	31	ns
t <sub>r</sub>	Rise Time	$V_{DD} = 30 \text{ V}, I_{D} = 14$			6.7	14	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	V <sub>GS</sub> = 10 V, R <sub>GEN</sub>	= 6 Ω		20	32	ns
t <sub>f</sub>	Fall Time		1		4	10	ns
$Q_q$	Total Gate Charge	V <sub>GS</sub> = 0 V to 10 V			28	40	nC
$Q_q$	Total Gate Charge	$V_{GS} = 0 V to 8 V$	$V_{DD} = 30 \text{ V},$		23	33	nC
$Q_{gs}$	Gate to Source Charge		I <sub>D</sub> = 14 A		10.9		nC
Q <sub>ad</sub>	Gate to Drain "Miller" Charge				5.6		nC

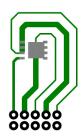
#### **Drain-Source Diode Characteristics**

V <sub>SD</sub>	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 2.1 \text{ A}$ (	Note 2)	0.74	1.2	\/
	Source to Drain Diode Forward voltage	$V_{GS} = 0 \text{ V}, I_S = 14 \text{ A}$ (	Note 2)	0.83	1.3	V
t <sub>rr</sub>	Reverse Recovery Time	-I <sub>F</sub> = 14 A, di/dt = 100 A/μs		37	60	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$-1_{\rm F} = 14 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{S}$		21	35	nC
t <sub>rr</sub>	Reverse Recovery Time	-I <sub>F</sub> = 14 A, di/dt = 300 A/μs		31	49	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$-1_F = 14 \text{ A}, \text{ di/dt} = 300 \text{ A/}\mu\text{S}$		40	64	nC

<sup>1</sup> R<sub>0JA</sub> is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>0JC</sub> is guaranteed by design while R<sub>0CA</sub> is determined by the user's board design.



a) 50 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b) 125 °C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300  $\mu s$ , Duty cycle < 2.0%. 3.  $E_{AS}$  of 86 mJ is based on starting  $T_J=25\,^{\circ}C$ , L = 0.3 mH,  $I_{AS}=24$  A,  $V_{DD}=54$  V,  $V_{GS}=10$  V.

## Typical Characteristics T<sub>J</sub> = 25 °C unless otherwise noted

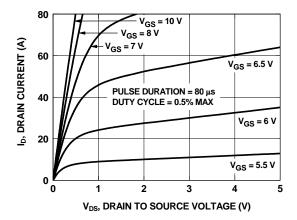


Figure 1. On-Region Characteristics

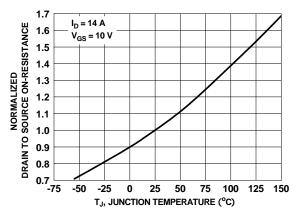


Figure 3. Normalized On-Resistance vs Junction Temperature

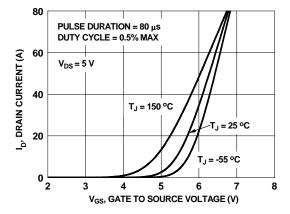


Figure 5. Transfer Characteristics

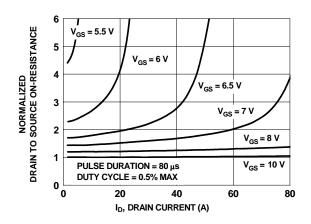


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

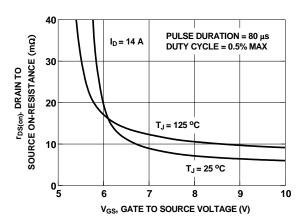


Figure 4. On-Resistance vs Gate to Source Voltage

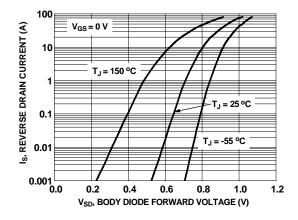


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

## **Typical Characteristics** $T_J = 25$ °C unless otherwise noted

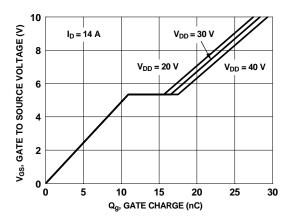


Figure 7. Gate Charge Characteristics

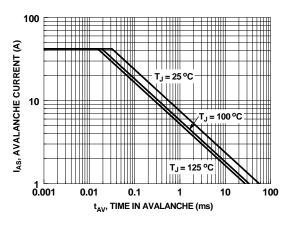


Figure 9. Unclamped Inductive Switching Capability

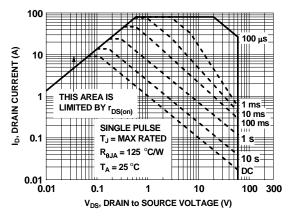


Figure 11. Forward Bias Safe Operating Area

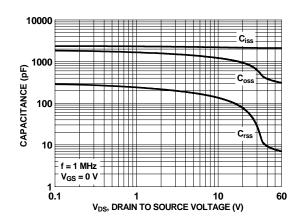


Figure 8. Capacitance vs Drain to Source Voltage

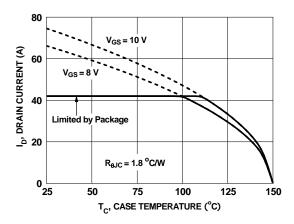


Figure 10. Maximum Continuous Drain Current vs Case Temperature

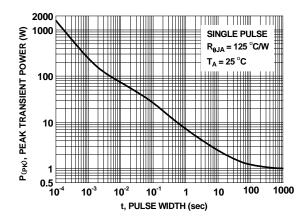


Figure 12. Single Pulse Maximum Power Dissipation

## Typical Characteristics $T_J = 25$ °C unless otherwise noted

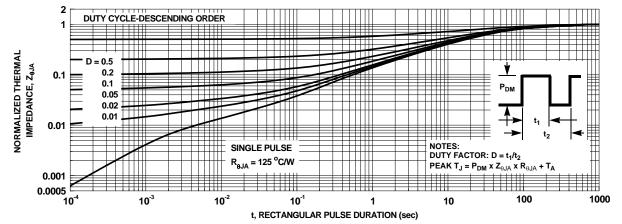
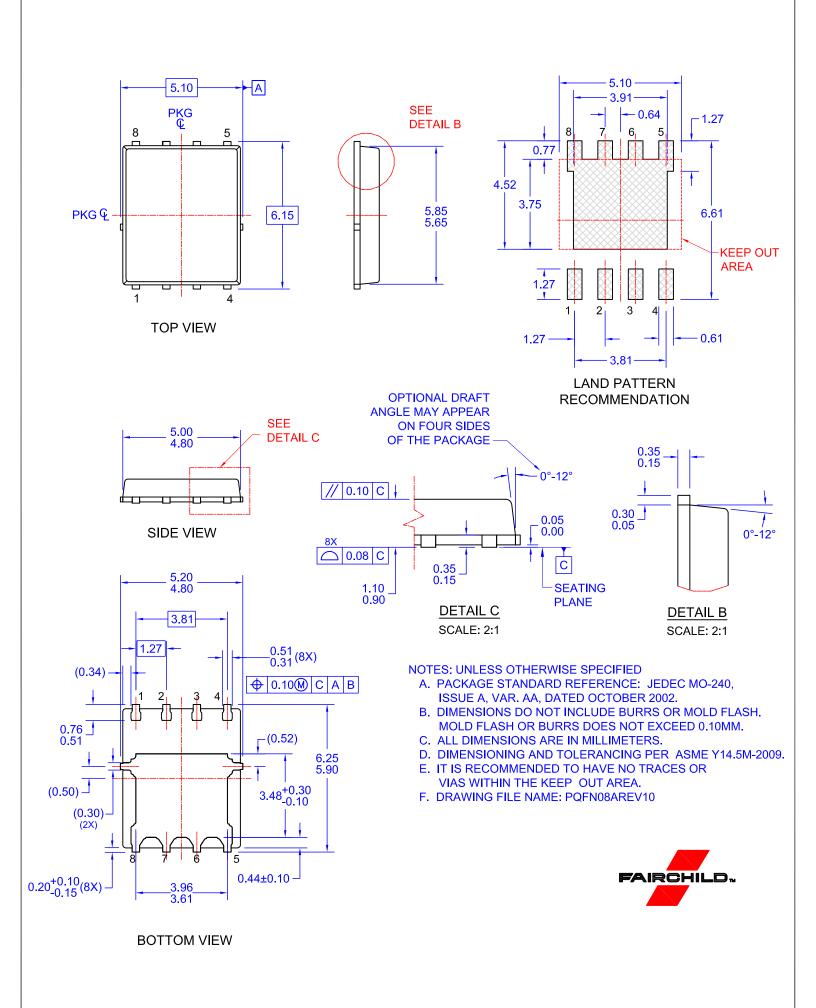


Figure 13. Junction-to-Ambient Transient Thermal Response Curve



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